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Nuclear Instruments and Methods in Physics Research B 113 (1996) 539–550

NIM B
Beam Interactions with Materials & Atoms

Author index

Abs, M., see Jongen, Y. . . . 113 (1996) 522
Adam, S., see Stammbach, Th. . . . 113 (1996) 1
Adamczewski, J., see Stephan, A. . . . 113 (1996) 387
Adams, L., see Hajdas, W. . . . 113 (1996) 54
Aerts, A.T., see Wijma, S. . . . 113 (1996) 465
Afonso, C.N., see Can, N. . . . 113 (1996) 248
Aguilar, M., see Blanco, J.M. . . . 113 (1996) 530
Agulló-López, F., see Kling, A. . . . 113 (1996) 293
Alexandreanu, B., see Racolta, P.M. . . . 113 (1996) 420
Almendra, A., see Rodríguez, T. . . . 113 (1996) 279
Alvarez-Brückmann, M., see Steinhausen, C. . . . 113 (1996) 479
Amaldi, U. and M. Silari, Biomedical applications of hadron accelerators . . . 113 (1996) 513
Amelia, J.-C., see Jongen, Y. . . . 113 (1996) 522
Ames, F., see Dittrich-Hannen, B. . . . 113 (1996) 453
Aminpirooz, S., see Paloura, E.C. . . . 113 (1996) 227
Anderson, O., see Laube, M. . . . 113 (1996) 288
Angert, N., see Tinschert, K. . . . 113 (1996) 59
Arps, M., see Markwitz, A. . . . 113 (1996) 223
Assmann, W., Th. Reichelt, T. Eisenhammer, H. Huber, A. Mahr, H. Schellinger and R. Wohlgemuth, ERDA of solar selective absorbers . . . 113 (1996) 303
Assmann, W., see Vlastou, R. . . . 113 (1996) 253
Aylett, B.J., see Giaddui, T. . . . 113 (1996) 201

Bachmann, T., E. Glaser, R. Schulz, U. Kaiser and G. Sáfrán, Epitaxial crystallization and nucleation during MeV-ion beam processing of amorphous GaAs surface layers . . . 113 (1996) 214
Bachmann, T., see Heft, A. . . . 113 (1996) 239
Baier, S., see Kubsky, S. . . . 113 (1996) 63
Balasubramanian, V., D.S. Kelkar and M.B. Kurup, Electrical conduction in ion implanted Nylon-6 films . . . 113 (1996) 257
Ballesteros, J.M., see Can, N. . . . 113 (1996) 248
Balogh, A.G., see Neubeck, K. . . . 113 (1996) 186
Baltensperger, U., see Parrat, Y. . . . 113 (1996) 470
Bange, K., see Laube, M. . . . 113 (1996) 288
Banu, V., see Iliescu, E. . . . 113 (1996) 103
Barcz, A., see Zaborowski, M. . . . 113 (1996) 191
Baumann, H., see Noli, F. . . . 113 (1996) 171
Baumann, H., see Hausner, R.M. . . . 113 (1996) 176
Baumann, H., see Symietz, I. . . . 113 (1996) 182
Baumann, H., see Neubeck, K. . . . 113 (1996) 186
Baumann, H., see Markwitz, A. . . . 113 (1996) 223
Baumann, H., see Link, F. . . . 113 (1996) 235
Bechstedt, U., J. Dietrich, R. Maier, S. Martin, D. Prasuhn, A. Schnase, H. Schneider, H. Stockhorst and R. Tölle, The cooler synchrotron COSY in Jülich . . . 113 (1996) 26
Becker, H.-W., see Kubsky, S. . . . 113 (1996) 63
Beeckman, W., see Jongen, Y. . . . 113 (1996) 522
Behar, M., see Fink, D. . . . 113 (1996) 244
Beisel, U., see Vormann, H. . . . 113 (1996) 38
Beller, P., see Stiebing, K. . . . 113 (1996) 34
Beloglazov, A., M. Martino and V. Nassisi, Excimer lasers induced electron beams on metal cathodes under a plasma effect . . . 113 (1996) 110
Bender, H., J. Brutscher, W. Ensinger, R. Günzel, J. Halder, H. Klein, B. Rauschenbach, J. Schäfer, B. Seiler and R. Thomae, Influence of plasma density and plasma sheath dynamics on the ion implantation by plasma immersion technique . . . 113 (1996) 266

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Berheide, M., see Kubsky, S. 113 (1996) 63
Bertschy, M., J. Jolie and W. Mondelaers, Improvement of heavy element tomography results using tunable gamma-ray beams 113 (1996) 146
Bertschy, M., see Stritt, N. 113 (1996) 150
Bessler, U., A. Schempp, H. Deitinghoff, A. Kipper, J. Klabunde, T. Sieber and P. Spädtke, Ar^+-beam experiments with the high-current heavy-ion Spiral-RFQ at GSI 113 (1996) 30
Bessler, U., see Stiebing, K. 113 (1996) 34
Bethge, K., see Stiebing, K. 113 (1996) 34
Bethge, K., see Hausner, R.M. 113 (1996) 176
Bethge, K., see Symietz, I. 113 (1996) 182
Bethge, K., see Neubeck, K. 113 (1996) 186
Bethge, K., see Markwitz, A. 113 (1996) 223
Bethge, K., see Paloura, E.C. 113 (1996) 227
Bethge, K., see Link, F. 113 (1996) 235
Bethge, K., see Soltani-Farshi, M. 113 (1996) 399
Bethge, K., see Vollmer, M. 113 (1996) 403
Beukens, R.P., see Kieser, W.E. 113 (1996) 461
Bin, L., see Sixun, Y. 113 (1996) 477
Blanco, J.M., J.J. Serrano, J. Jiménez-Leube, T. Rodríguez, M. Aguilar and R. Gwilliam, SIMS characterization of thin layers of IR and its silicides 113 (1996) 530
Bogdanović, I., see Jakšić, M. 113 (1996) 378
Bogovac, M., see Jakšić, M. 113 (1996) 378
Bohne, W., S. Hessler and G. Röschert, Beam-current measurement based on residual gas ionization 113 (1996) 78
Borges, L., see Michel, R. 113 (1996) 434
Borucki, L., see Kubsky, S. 113 (1996) 63
Bouix, J., see Somatri, R. 113 (1996) 284
Brijs, B., see Deleu, J. 113 (1996) 534
Brutscher, J., see Bender, H. 113 (1996) 266
Bubb, I.F., see Walker, S.R. 113 (1996) 312
Bukow, H.H., see Stephan, A. 113 (1996) 387
Buoso, M.C., see Olabanji, S.O. 113 (1996) 368
Burns, P., N.H. Drewell and J. McKeown, The measurement, control, and validation of critical parameters in an electron beam sterilization facility 113 (1996) 96
Butz, T. and G.J.F. Legge, From micro- to nanoprobes: auspices and horizons 113 (1996) 317
Butz, T., see Krause, H. 113 (1996) 209

Cachoncinlle, C., see Pouvesle, J.M. 113 (1996) 134
Can, N., P.D. Townsend, D.E. Hole, J.M. Ballesteros, C.N. Afonso and H.V. Snelling, Influence of pulsed laser annealing on rare earth implanted luminescence 113 (1996) 248
Ceccato, D., see Olabanji, S.O. 113 (1996) 368
Chadderton, L.T., see Fink, D. 113 (1996) 244
Chailan, J.F., see Somatri, R. 113 (1996) 284
Cherubini, R., see Olabanji, S.O. 113 (1996) 368
Chevallier, P., P. Dhez, A. Erko, A. Firsov, F. Legrand and P. Populus, X-ray microprobes 113 (1996) 122
Chevarier, A., see Somatri, R. 113 (1996) 284
Chevarier, N., see Somatri, R. 113 (1996) 284
Cohen, D.D., see Walker, S.R. 113 (1996) 312
Cojocaru, G., see Martin, D. 113 (1996) 106
Conti, M., see Giorginis, G. 113 (1996) 396
Correia, J.G., Radioactive ion beams for solid state research 113 (1996) 501
Correia, J.G., see Kling, A. 113 (1996) 293
Craig, S.T., see Drewell, N.H. 113 (1996) 93
Cramariuc, R., see Marghitu, S. 113 (1996) 114
Crametz, A., see Giorginis, G. 113 (1996) 396
Currie, P.J., see Forster, J.S. 113 (1996) 308

Dargie, M., see Valkovic, V. 113 (1996) 363
Da Silva, M.F., see Rodríguez, T. 113 (1996) 279
Da Silva, M.F., see Kling, A. 113 (1996) 293
Davies, J.A., see Forster, J.S. 113 (1996) 308

De Coster, W., see Deleu, J. . . . 113 (1996) 534
Deitinghoff, H., see Bessler, U. . . . 113 (1996) 30
Del Carmine, P., L. Giuntini, W. Hooper, F. Lucarelli and P.A. Mandò, Further results from PIXE analysis of inks in Galileo's notes on motion . . . 113 (1996) 354
Deleu, J., B. Brijs, W. Storm, W. Vandervorst and W. De Coster, The behaviour of Si and $CoSi_2$ during low energy nitrogen bombardment, with and without O_2-flooding . . . 113 (1996) 534
Demortier, G., Ion beam studies of archaeological gold jewellery items . . . 113 (1996) 347
Demortier, G., see Ruvalcaba-Sil, J.L. . . . 113 (1996) 275
De Voigt, M.J.A., see van Maanen, I.F. . . . 113 (1996) 382
De Voigt, M.J.A., see Maj, B. . . . 113 (1996) 391
De Voigt, M.J.A., see van IJzendoorn, L.J. . . . 113 (1996) 411
Dhez, P., see Chevallier, P. . . . 113 (1996) 122
Diéguez, E., see Kling, A. . . . 113 (1996) 293
Dietrich, J., see Bechstedt, U. . . . 113 (1996) 26
Ditrói, F. and I. Mahunka, Thin layer activation of non-metallic materials by using nuclear implantation . . . 113 (1996) 415
Dittrich-Hannen, B., F. Ames, M. Suter, M.J.M. Wagner, Ch. Schnabel, R. Michel, U. Herpers and E. Günther, ^{41}Ca measurements at the Zurich AMS facility . . . 113 (1996) 453
Dittrich-Hannen, B., see Wagner, M.J.M. . . . 113 (1996) 490
Döbeli, M., see Nebiker, P.W. . . . 113 (1996) 205
Dooley, S.P., see Walker, S.R. . . . 113 (1996) 312
Dragusin, M., see Martin, D. . . . 113 (1996) 106
Drewell, N.H., S. Sandri, S.T. Craig, Frketich and D.L. Smyth, Custom-tailored dose with the IMPELA electron irradiator . . . 113 (1996) 93
Drewell, N.H., see Burns, P. . . . 113 (1996) 96
Drigo, A., see Turos, A. . . . 113 (1996) 261
Dumitru, M., see Steinhausen, C. . . . 113 (1996) 479
Dytlewski, N., see Walker, S.R. . . . 113 (1996) 312

Earwaker, L.G., see Giaddui, T. . . . 113 (1996) 201
Eisenhammer, T., see Assmann, W. . . . 113 (1996) 303
Elliman, R.G., see Russo, S.P. . . . 113 (1996) 218
Emig, H., see Tinschert, K. . . . 113 (1996) 59
Engels, O., J. Häuser, H. Homeyer, F. Marhauser, W. Pelzer and A. Schempp, A new injector for the ISL-cyclotron at HMI . . . 113 (1996) 16
Engels, O., see Vormann, H. . . . 113 (1996) 38
Ensinger, W., see Bender, H. . . . 113 (1996) 266
Erko, A., see Chevallier, P. . . . 113 (1996) 122
Erlandsson, B., see Stenström, K. . . . 113 (1996) 474

Falcone, R., see Turos, A. . . . 113 (1996) 261
Fazinić, S., see Jakšić, M. . . . 113 (1996) 378
Ferdes, O., see Minea, R. . . . 113 (1996) 99
Ferro, G., see Somatri, R. . . . 113 (1996) 284
Filges, D., see Gloris, M. . . . 113 (1996) 429
Fink, D., L.T. Chadderton, J. Vacik, V. Hnatowicz, F.C. Zawislak, M. Behar and P.L. Grande, Damage and sputtering of fullerene by low energy medium and heavy ions . . . 113 (1996) 244
Fink, D., see Hotchkis, M.A.C. . . . 113 (1996) 457
Firsov, A., see Chevallier, P. . . . 113 (1996) 122
Fitze, H.R., see Stammbach, Th. . . . 113 (1996) 1
Flagmeyer, R.-H., see Krause, H. . . . 113 (1996) 209
Forcey, K.S., see Giaddui, T. . . . 113 (1996) 201
Formenti, P., P. Prati, A. Zucchiatti, F. Lucarelli and P.A. Mandò, Aerosol study in the town of Genova with a PIXE analysis . . . 113 (1996) 359
Forster, J.S., P.J. Currie, J.A. Davies, R. Siegele, S.G. Wallace and D. Zelenitsky, Elastic recoil detection (ERD) with extremely heavy ions . . . 113 (1996) 308
Frketich, see Drewell, N.H. . . . 113 (1996) 93

Gäggeler, H.W., see Parrat, Y. . . . 113 (1996) 470
Gaillard, G., Accelerator based X-ray facilities applied to freight control . . . 113 (1996) 128
Galassini, S., see Jakšić, M. . . . 113 (1996) 378

Garnir, H.P., see Strivay, D. 113 (1996) 407
Gast, W., see Stein, J. 113 (1996) 141
Gawlik, G., see Zaborowski, M. 113 (1996) 191
Gazis, E.N., see Vlastou, R. 113 (1996) 253
Geiss, O., see Walter, G. 113 (1996) 167
Gellert, R., see Walter, G. 113 (1996) 167
Georgiev, A., see Stein, J. 113 (1996) 141
Gerisch, P., see Steinhausen, C. 113 (1996) 479
Gerlach, J.W., see Wengenmair, H. 113 (1996) 196
Giaddui, T., L.G. Earwaker, K.S. Forcey, B.J. Aylett and I.S. Harding, A study on the metallisation and stabilisation of porous silicon 113 (1996) 201
Ginoudi, A., see Paloura, E.C. 113 (1996) 227
Giorginis, G., P. Misaelides, A. Crametz and M. Conti, Cross section of the $^{14}N(\alpha,P_0)^{17}O$ nuclear reaction for analytical applications 113 (1996) 396
Giorginis, G., see Noli, F. 113 (1996) 171
Giuntini, L., see Del Carmine, P. 113 (1996) 354
Glaser, E., see Bachmann, T. 113 (1996) 214
Glaser, E., see Heft, A. 113 (1996) 239
Gloris, M., R. Michel, U. Herpers, F. Sudbrock and D. Filges, Production of residual nuclei from irradiation of thin Pb-targets with protons up to 1.6 GeV 113 (1996) 429
Gloris, M., see Schiekel, Th. 113 (1996) 484
Godelitsas, A., see Misaelides, P. 113 (1996) 296
Gorev, V.V., K.O. Kachalov, V.I. Kleonsky and K.S. Serebrennikov, High-current positron beams in γ-defectoscopy . 113 (1996) 526
Gorris, F., see Kubsky, S. 113 (1996) 63
Grande, P.L., see Fink, D. 113 (1996) 244
Grunwald, C., see Kubsky, S. 113 (1996) 63
Günther, E., see Dittrich-Hannen, B. 113 (1996) 453
Günzel, R., see Bender, H. 113 (1996) 266
Gutt, T., see Kubsky, S. 113 (1996) 63
Gwilliam, R., see Blanco, J.M. 113 (1996) 530

Hahn, H., see Neubeck, K. 113 (1996) 186
Hajdas, W., L. Adams, B. Nickson and A. Zehnder, The Proton Irradiation Facility at the Paul Scherrer Institute . . . 113 (1996) 54
Hajdas, W., see Parrat, Y. 113 (1996) 470
Halder, J., see Bender, H. 113 (1996) 266
Haque, A.M.I., see Olabanji, S.O. 113 (1996) 368
Harding, I.S., see Giaddui, T. 113 (1996) 201
Hartmann, B., S. Kalbitzer and Ch. Klatt, Energy widths of ion beams from a tandem accelerator 113 (1996) 50
Hatanaka, K., see Sato, K. 113 (1996) 42
Hattori, T., see Ito, T. 113 (1996) 46
Hattori, T., see Sasa, K. 113 (1996) 67
Häuser, J., see Engels, O. 113 (1996) 16
Hausner, R., see Noli, F. 113 (1996) 171
Hausner, R., see Neubeck, K. 113 (1996) 186
Hausner, R.M., H. Baumann and K. Bethge, Aluminum ion implantation under backfilling oxygen 113 (1996) 176
Haverlag, M., see van IJzendoorn, L.J. 113 (1996) 411
Hayashizaki, N., see Sasa, K. 113 (1996) 67
Heft, A., E. Wendler, J. Heindl, T. Bachmann, E. Glaser, H.P. Strunk and W. Wesch, Damage production and annealing of ion implanted silicon carbide 113 (1996) 239
Heiberger, M., see Jongen, Y. 113 (1996) 522
Heindl, J., see Heft, A. 113 (1996) 239
Heisinger, B., see Steinhausen, C. 113 (1996) 479
Heitzmann, R., see Walter, G. 113 (1996) 167
Hellborg, R., see Stenström, K. 113 (1996) 474
Herpers, U., see Gloris, M. 113 (1996) 429
Herpers, U., see Dittrich-Hannen, B. 113 (1996) 453
Herpers, U., see Schiekel, Th. 113 (1996) 484
Hessler, S., see Bohne, W. 113 (1996) 78
Hnatowicz, V., see Fink, D. 113 (1996) 244
Hohl, Ch., see Steinhausen, C. 113 (1996) 479

Hole, D.E., see Can, N. 113 (1996) 248
Holldack, K., see Paloura, E.C. 113 (1996) 231
Holub-Krappe, E., see Paloura, E.C. 113 (1996) 227
Homeyer, H., see Engels, O. 113 (1996) 16
Hooper, W., see Del Carmine, P. 113 (1996) 354
Hosokawa, T., see Yamada, K. 113 (1996) 119
Hosono, K., see Sato, K. 113 (1996) 42
Hotchkis, M.A.C., D. Fink, Q. Hua, G.E. Jacobsen, E.M. Lawson, A.M. Smith and C. Tuniz, High-precision radiocarbon measurements at the ANTARES AMS Centre 113 (1996) 457
Hua, Q., see Hotchkis, M.A.C. 113 (1996) 457
Hubbard, E., see Jongen, Y. 113 (1996) 522
Huber, H., see Vlastou, R. 113 (1996) 253
Huber, H., see Assmann, W. 113 (1996) 303
Hurn, T., see Jongen, Y. 113 (1996) 522

Iliescu, E. and V. Banu, Electron beam technology for improvement of the recovery characteristics of power thyristors 113 (1996) 103
Ishii, Y., R. Tanaka and A. Isoya, Low-energy ion source characteristics for producing an ultra-fine microbeam 113 (1996) 75
Isoya, A., see Ishii, Y. 113 (1996) 75
Itahashi, T., M. Kondo and T. Yamagata, Technique for fluence attenuation by acceleration of decay particles 113 (1996) 21
Itahashi, T., see Sato, K. 113 (1996) 42
Ito, T., S. Yamaki, M. Okamura, K. Sasa, H. Schubert and T. Hattori, Development of heavy ion IHQ linac for material irradiation 113 (1996) 46
Ito, T., see Sasa, K. 113 (1996) 67
Ittel, T.H., see Steinhausen, C. 113 (1996) 479

Jacobsen, G.E., see Hotchkis, M.A.C. 113 (1996) 457
Jakšić, M., I. Bogdanović, M. Bogovac, S. Fazinić, S. Galassini, K. Kovačević, C. Manfredotti and E. Vittone, Testing of radiation detectors by IBIC imaging 113 (1996) 378
Jaksic, M., see Valkovic, V. 113 (1996) 363
Jamieson, D.N., see Russo, S.P. 113 (1996) 218
Jamieson, D.N., see Walker, S.R. 113 (1996) 312
Jianjun, W., see Sixun, Y. 113 (1996) 477
Jiménez-Leube, J., see Blanco, J.M. 113 (1996) 530
Johnston, P.N., see Russo, S.P. 113 (1996) 218
Johnston, P.N., see Walker, S.R. 113 (1996) 312
Joho, W., see Stammbach, Th. 113 (1996) 1
Jolie, J., see Bertschy, M. 113 (1996) 146
Jolie, J., see Stritt, N. 113 (1996) 150
Jongen, Y., S. Laycock, M. Abs, J.-C. Amelia, W. Beeckman, W. Kleeven, M. Ladeuze, G. Lannoye, D. Leyman, V. Poreye, D. Vandeplassche, S. Zaremba, T. Hurn, L. Nissley, E. Hubbard, M. Heiberger, M. Tabor, C. Silke, T. Tachikawa, M. Sano, T. Takayama, K. Ohtomo and T. Satoh, The proton therapy system for the NPTC: equipment description and progress report 113 (1996) 522

Kachalov, K.O., see Gorev, V.V. 113 (1996) 526
Kaiser, U., see Bachmann, T. 113 (1996) 214
Kalbitzer, S., Ch. Wilbertz, Th. Miller and A. Knoblauch, Ion beam modification for submicron technology 113 (1996) 154
Kalbitzer, S., see Hartmann, B. 113 (1996) 50
Kaneko, T., see Yamada, K. 113 (1996) 119
Kankeleit, E., see Walter, G. 113 (1996) 167
Katsikini, M., see Paloura, E.C. 113 (1996) 227
Kelkar, D.S., see Balasubramanian, V. 113 (1996) 257
Kexin, L., see Sixun, Y. 113 (1996) 477
Khacef, A., see Pouvesle, J.M. 113 (1996) 134
Kieser, W.E., A.E. Litherland, X.-L. Zhao, L.R. Kilius and R.P. Beukens, A high capacity ion source for AMS 113 (1996) 461
Kilius, L.R., see Purser, K.H. 113 (1996) 445
Kilius, L.R., see Kieser, W.E. 113 (1996) 461
Kimura, K. and M.-h. Mannami, RBS with monolayer resolution 113 (1996) 270
Kipper, A., see Bessler, U. 113 (1996) 30
Kislinger, G., see Steinhausen, C. 113 (1996) 479
Kiss, L., Computer simulation for electrostatic lenses by using piecewise polynomials 113 (1996) 71

Klabunde, J., see Bessler, U. 113 (1996) 30
Klatt, Ch., see Hartmann, B. 113 (1996) 50
Kleeven, W., see Jongen, Y. 113 (1996) 522
Klein, H., see Bender, H. 113 (1996) 266
Kleonsky, V.I., see Gorev, V.V. 113 (1996) 526
Kling, A., J.G. Marques, J.G. Correia, M.F. da Silva, E. Diéguez, F. Agulló-López and J.C. Soares, Study of structural differences between stoichiometric and congruent lithium niobate 113 (1996) 293
Kling, A., see Krause, H. 113 (1996) 209
Klingelhöfer, G., see Walter, G. 113 (1996) 167
Knoblauch, A., see Kalbitzer, S. 113 (1996) 154
Kokkoris, M., see Vlastou, R. 113 (1996) 253
Kondo, M., see Itahashi, T. 113 (1996) 21
Korschinek, G., see Steinhausen, C. 113 (1996) 479
Kossionides, S., see Vlastou, R. 113 (1996) 253
Kossionidis, S., see Misaelides, P. 113 (1996) 296
Kovačević, K., see Jakšić, M. 113 (1996) 378
Kovács, Z., see Takács, S. 113 (1996) 424
Krause, H., R.-H. Flagmeyer, J. Vogt, A. Kling and T. Butz, Defect development and dopant location due to elevated temperature implantation of InP with MeV zinc ions 113 (1996) 209
Krimmel, E.F., see Markwitz, A. 113 (1996) 223
Krimmel, E.F., see Link, F. 113 (1996) 235
Krüger, G., see Kubsky, S. 113 (1996) 63
Kubik, P.W., see Parrat, Y. 113 (1996) 470
Kubsky, S., L. Borucki, M. Berheide, S. Baier, H.-W. Becker, F. Gorris, C. Grunwald, T. Gutt, G. Krüger, M. Mehrhoff, N. Piel, W.H. Schulte and C. Rolfs, Concept and status of the new sample preparation and analyzing facility at Bochum 113 (1996) 63
Kun, L., see Sixun, Y. 113 (1996) 477
Kuroda, K., see Yamada, K. 113 (1996) 119
Kurup, M.B., see Balasubramanian, V. 113 (1996) 257

Ladeuze, M., see Jongen, Y. 113 (1996) 522
Lannoye, G., see Jongen, Y. 113 (1996) 522
Laube, M., F. Rauch, C. Ottermann, O. Anderson and K. Bange, Density of thin TiO_2 films 113 (1996) 288
Lawson, E.M., see Hotchkis, M.A.C. 113 (1996) 457
Laycock, S., see Jongen, Y. 113 (1996) 522
Legge, G.J.F., see Butz, T. 113 (1996) 317
Legrand, F., see Chevallier, P. 113 (1996) 122
Leible, K., see Tinschert, K. 113 (1996) 59
Leray, S., Nuclear waste transmutation 113 (1996) 495
Leya, I., see Michel, R. 113 (1996) 434
Leya, I., see Schiekel, Th. 113 (1996) 484
Leyman, D., see Jongen, Y. 113 (1996) 522
Li, D., see Vormann, H. 113 (1996) 38
Liarokapis, E., see Vlastou, R. 113 (1996) 253
Lieb, K.P., see Lupascu, D. 113 (1996) 507
Link, F., H. Baumann, A. Markwitz, E.F. Krimmel and K. Bethge, Low-energy ^{15}N implantation in carbon for the synthesis of carbon nitride layers 113 (1996) 235
Lioutas, Ch., see Paloura, E.C. 113 (1996) 227
Litherland, A.E., see Purser, K.H. 113 (1996) 445
Litherland, A.E., see Kieser, W.E. 113 (1996) 461
Löffelmacher, D., see Stephan, A. 113 (1996) 387
Lucarelli, F., see Del Carmine, P. 113 (1996) 354
Lucarelli, F., see Formenti, P. 113 (1996) 359
Lupascu, D., M. Neubauer, T. Wenzel, M. Uhrmacher and K.P. Lieb, Perturbed angular correlations in metal oxides with radioactive tracer beams 113 (1996) 507

Madlung, J., see Stiebing, K. 113 (1996) 34
Mahr, A., see Assmann, W. 113 (1996) 303
Mahunka, I., see Ditrói, F. 113 (1996) 415
Maier, R., see Bechstedt, U. 113 (1996) 26

Maj, B., P.H.A. Mutsaers, E. Rokita and M.J.A. de Voigt, Determination of the microbeam profile using deconvolution procedures . . . 113 (1996) 391
Makanju, O.V., see Olabanji, S.O. . . . 113 (1996) 368
Malmqvist, K.G., Applications of nuclear microprobes in environmental research . . . 113 (1996) 336
Mandò, P.A., see Del Carmine, P. . . . 113 (1996) 354
Mandò, P.A., see Formenti, P. . . . 113 (1996) 359
Manfredotti, C., see Jakšić, M. . . . 113 (1996) 378
Mannami, M.-h., see Kimura, K. . . . 113 (1996) 270
Manos, G., see Misaelides, P. . . . 113 (1996) 296
Marghitu, O., see Marghitu, S. . . . 113 (1996) 114
Marghitu, S., D. Martin, C. Oproiu, O. Marghitu and R. Cramariuc, Computer aided simulations of high current small energy electron beam channels . . . 113 (1996) 114
Marghitu, S., see Martin, D. . . . 113 (1996) 106
Marhauser, F., see Engels, O. . . . 113 (1996) 16
Märki, M., see Stammbach, Th. . . . 113 (1996) 1
Markowicz, A., see Valkovic, V. . . . 113 (1996) 363
Markwitz, A., M. Arps, H. Baumann, E.F. Krimmel and K. Bethge, Depth profile analysis and study of the electronic properties of silicon nitride layers produced by ion implantation . . . 113 (1996) 223
Markwitz, A., see Paloura, E.C. . . . 113 (1996) 227
Markwitz, A., see Link, F. . . . 113 (1996) 235
Marques, J.G., see Kling, A. . . . 113 (1996) 293
Martin, D., M. Dragusin, A. Radu, C. Oproiu, M. Radoiu, G. Cojocaru and S. Marghitu, IAP linacs in applied research . . . 113 (1996) 106
Martin, D., see Marghitu, S. . . . 113 (1996) 114
Martin, J.W., see Walker, S.R. . . . 113 (1996) 312
Martin, S., see Bechstedt, U. . . . 113 (1996) 26
Martino, M., see Beloglazov, A. . . . 113 (1996) 110
Matei, C., see Minea, R. . . . 113 (1996) 99
Matzke, Hj., see Turos, A. . . . 113 (1996) 261
McKeown, J., see Burns, P. . . . 113 (1996) 96
Mehnert, R., Review of industrial applications of electron accelerators . . . 113 (1996) 81
Mehrhoff, M., see Kubsky, S. . . . 113 (1996) 63
Meijer, J., see Stephan, A. . . . 113 (1996) 387
Mertens, A., see Paloura, E.C. . . . 113 (1996) 231
Meyer, J.D., see Soltani-Farshi, M. . . . 113 (1996) 399
Meyer, J.D., see Vollmer, M. . . . 113 (1996) 403
Michel, R., I. Leya and L. Borges, Production of cosmogenic nuclides in meteoroids: accelerator experiments and model calculations to decipher the cosmic ray record in extraterrestrial matter . . . 113 (1996) 434
Michel, R., see Gloris, M. . . . 113 (1996) 429
Michel, R., see Dittrich-Hannen, B. . . . 113 (1996) 453
Michel, R., see Schiekel, Th. . . . 113 (1996) 484
Michelmann, R.W., see Vollmer, M. . . . 113 (1996) 403
Miller, Th., see Kalbitzer, S. . . . 113 (1996) 154
Minea, R., C. Oproiu, S. Pascanu, C. Matei and O. Ferdes, Preliminary research concerning the use of electron accelerators to improve the conservability and to extend the shelf-life of fruits and vegetables . . . 113 (1996) 99
Misaelides, P., A. Godelitsas, S. Kossionidis and G. Manos, Investigation of chemical processes at mineral surfaces using accelerator-based and surface analytical techniques: heavy metal sorption on zeolite crystals . . . 113 (1996) 296
Misaelides, P., see Noli, F. . . . 113 (1996) 171
Misaelides, P., see Giorginis, G. . . . 113 (1996) 396
Misaelides, P., see Soltani-Farshi, M. . . . 113 (1996) 399
Miura, I., see Sato, K. . . . 113 (1996) 42
Mondelaers, W., see Bertschy, M. . . . 113 (1996) 146
Mondelaers, W., see Stritt, N. . . . 113 (1996) 150
Monteil, Y., see Somatri, R. . . . 113 (1996) 284
Morii, Y., see Sato, K. . . . 113 (1996) 42
Moschini, G., see Olabanji, S.O. . . . 113 (1996) 368
Mühle, R., see Nebiker, P.W. . . . 113 (1996) 205
Mutsaers, P.H.A., Nuclear microprobe design . . . 113 (1996) 323
Mutsaers, P.H.A., see van Maanen, I.F. . . . 113 (1996) 382
Mutsaers, P.H.A., see Maj, B. . . . 113 (1996) 391

Nakajima, M., see Yamada, K. 113 (1996) 119
Nassisi, V., see Beloglazov, A. 113 (1996) 110
Nebiker, P.W., M. Döbeli, R. Mühle, M. Suter and D. Vetterli, Low energy ion beam irradiation of silicon 113 (1996) 205
Neubauer, M., see Lupascu, D. 113 (1996) 507
Neubeck, K., H. Hahn, A.G. Balogh, R. Hausner, H. Baumann, K. Bethge and D.M. Rück, Ion beam mixing at copper/alumina interfaces using marker geometry 113 (1996) 186
Nickson, B., see Hajdas, W. 113 (1996) 54
Niedermayer, M., see Steinhausen, C. 113 (1996) 479
Nissley, L., see Jongen, Y. 113 (1996) 522
Noli, F., P. Misaelides, G. Giorginis, H. Baumann and R. Hausner, Application of nuclear analytical and electron microscopic techniques to the investigation of the oxidation behavior of Mg-implanted steel samples 113 (1996) 171
Nolte, E., see Steinhausen, C. 113 (1996) 479

Oguri, Y., see Sasa, K. 113 (1996) 67
Ohtomo, K., see Jongen, Y. 113 (1996) 522
Okada, M., see Sasa, K. 113 (1996) 67
Okamura, M., see Ito, T. 113 (1996) 46
Okamura, M., see Sasa, K. 113 (1996) 67
Olabanji, S.O., O.V. Makanju, A.M.I. Haque, M.C. Buoso, D. Ceccato, R. Cherubini and G. Moschini, PIGE–PIXE analysis of chewing sticks of pharmacological importance 113 (1996) 368
Olivo, M., see Stammbach, Th. 113 (1996) 1
Oproiu, C., see Minea, R. 113 (1996) 99
Oproiu, C., see Martin, D. 113 (1996) 106
Oproiu, C., see Marghitu, S. 113 (1996) 114
Ottermann, C., see Laube, M. 113 (1996) 288

Palles, D., see Vlastou, R. 113 (1996) 253
Paloura, E.C., A. Ginoudi, A. Markwitz, Ch. Lioutas, M. Katsikini, K. Bethge, S. Aminpirooz, H. Rossner, E. Holub-Krappe, T. Zorba and D. Siapkas, Microstructural characterization of stoichiometric buried Si_3N_4 films . . 113 (1996) 227
Paloura, E.C., A. Mertens and K. Holldack, The effect of ion implantation in the microstructure of Si_3N_4 films: an X-ray absorption study 113 (1996) 231
Papadopoulos, C.T., see Vlastou, R. 113 (1996) 253
Parrat, Y., W. Hajdas, U. Baltensperger, H.-A. Synal, P.W. Kubik, M. Suter and H.W. Gäggeler, Cross section measurements of proton induced reactions using a gas target 113 (1996) 470
Pascanu, S., see Minea, R. 113 (1996) 99
Pelzer, W., see Engels, O. 113 (1996) 16
Piel, N., see Kubsky, S. 113 (1996) 63
Pilakouta, M., see Vlastou, R. 113 (1996) 253
Politiek, J., see van IJzendoorn, L.J. 113 (1996) 411
Popa-Simil, L., see Racolta, P.M. 113 (1996) 420
Populus, P., see Chevallier, P. 113 (1996) 122
Poreye, V., see Jongen, Y. 113 (1996) 522
Pouvesle, J.M., C. Cachoncinlle, R. Viladrosa, E. Robert and A. Khacef, Compact flash X-ray sources and their applications 113 (1996) 134
Prasuhn, D., see Bechstedt, U. 113 (1996) 26
Prati, P., see Formenti, P. 113 (1996) 359
Preckwinkel, U., see Wengenmair, H. 113 (1996) 196
Purser, K.H., L.R. Kilius, A.E. Litherland and X. Zhao, Detection of ^{236}U: a possible 100-million year neutron flux integrator 113 (1996) 445

Racolta, P.M., L. Popa-Simil and B. Alexandreanu, Ion beam-based studies for tribological phenomena 113 (1996) 420
Radoiu, M., see Martin, D. 113 (1996) 106
Radu, A., see Martin, D. 113 (1996) 106
Rajchel, B., BSCAT: Code for simulation and for analysis of the RBS/NRA spectra 113 (1996) 300
Rauch, F., see Laube, M. 113 (1996) 288
Rauschenbach, B., see Wengenmair, H. 113 (1996) 196
Rauschenbach, B., see Bender, H. 113 (1996) 266
Reichelt, Th., see Assmann, W. 113 (1996) 303
Rezzonico, L., see Stammbach, Th. 113 (1996) 1
Rizawa, T., see Sato, K. 113 (1996) 42

Robert, E., see Pouvesle, J.M. 113 (1996) 134
Röcken, H., see Stephan, A. 113 (1996) 387
Rodríguez, A., see Rodríguez, T. 113 (1996) 279
Rodríguez, T., A. Almendra, M.F. da Silva, J.C. Soares, H. Wolters, A. Rodríguez and J. Sanz-Maudes, RBS characterization of iridium silicides formed by RTA in vacuum 113 (1996) 279
Rodríguez, T., see Blanco, J.M. 113 (1996) 530
Rokita, E., see Maj, B. 113 (1996) 391
Rolfs, C., see Kubsky, S. 113 (1996) 63
Rolfs, C., see Stephan, A. 113 (1996) 387
Röschert, G., see Bohne, W. 113 (1996) 78
Rossner, H., see Paloura, E.C. 113 (1996) 227
Rück, D.M., see Tinschert, K. 113 (1996) 59
Rück, D.M., see Walter, G. 113 (1996) 167
Rück, D.M., see Neubeck, K. 113 (1996) 186
Russo, S.P., P.N. Johnston, R.G. Elliman and D.N. Jamieson, Light ion induced damage in CdTe and Hg(1 − *x*)Cd(*x*)Te epitaxial thin films 113 (1996) 218
Ruvalcaba-Sil, J.L. and G. Demortier, Elemental concentration profile in ancient gold artifacts by ion beam scattering . 113 (1996) 275

Sáfrán, G., see Bachmann, T. 113 (1996) 214
Saito, T., see Sato, K. 113 (1996) 42
Sambo, A., see Turos, A. 113 (1996) 261
Sandri, S., see Drewell, N.H. 113 (1996) 93
Sano, M., see Jongen, Y. 113 (1996) 522
Sanz-Maudes, J., see Rodríguez, T. 113 (1996) 279
Sasa, K., Y. Oguri, M. Okamura, M. Okada, T. Ito, N. Hayashizaki and T. Hattori, Fine-focusing system of intense beams for application of ion-induced plasma 113 (1996) 67
Sasa, K., see Ito, T. 113 (1996) 46
Sato, K., T. Rizawa, T. Saito, H. Tamura, M. Uraki, M. Yamamoto, Y. Morii, K. Hosono, K. Hatanaka, T. Itahashi, K. Takahisa, K. Tamura and I. Miura, Study on a tuning-free network for the rf accelerating cavity 113 (1996) 42
Satoh, T., see Jongen, Y. 113 (1996) 522
Schäfer, J., see Bender, H. 113 (1996) 266
Schellinger, H., see Assmann, W. 113 (1996) 303
Schempp, A., see Engels, O. 113 (1996) 16
Schempp, A., see Bessler, U. 113 (1996) 30
Schempp, A., see Stiebing, K. 113 (1996) 34
Schempp, A., see Vormann, H. 113 (1996) 38
Scheuer, F., see Stein, J. 113 (1996) 141
Schiekel, Th., F. Sudbrock, U. Herpers, M. Gloris, I. Leya, R. Michel, H.-A. Synal and M. Suter, On the production of ^{36}Cl by high energy protons in thin and thick targets 113 (1996) 484
Schmidt-Böcking, H., see Stiebing, K. 113 (1996) 34
Schmidt, L., see Stiebing, K. 113 (1996) 34
Schnabel, Ch., see Dittrich-Hannen, B. 113 (1996) 453
Schnase, A., see Bechstedt, U. 113 (1996) 26
Schneider, H., see Bechstedt, U. 113 (1996) 26
Schneider, M., see Steinhausen, C. 113 (1996) 479
Schotterer, U., see Wagner, M.J.M. 113 (1996) 490
Schremmer, A., see Stiebing, K. 113 (1996) 34
Schryber, U., see Stammbach, Th. 113 (1996) 1
Schubert, H., see Ito, T. 113 (1996) 46
Schulte, W.H., see Kubsky, S. 113 (1996) 63
Schulz, R., see Bachmann, T. 113 (1996) 214
Seiler, B., see Bender, H. 113 (1996) 266
Serebrennikov, K.S., see Gorev, V.V. 113 (1996) 526
Serrano, J.J., see Blanco, J.M. 113 (1996) 530
Shijun, G., see Sixun, Y. 113 (1996) 477
Siapkas, D., see Paloura, E.C. 113 (1996) 227
Sieber, T., see Bessler, U. 113 (1996) 30
Siegele, R., see Forster, J.S. 113 (1996) 308
Sigg, P., see Stammbach, Th. 113 (1996) 1
Sigle, W., Focused high-voltage electron beams in material science 113 (1996) 88

Silari, M., see Amaldi, U. . . . 113 (1996) 513
Silke, C., see Jongen, Y. . . . 113 (1996) 522
Sixun, Y., G. Zhiyu, W. Jianjun, G. Shijun, L. Kun, L. Kexin, L. Xiangyang and L. Bin, AMS ^{14}C dating of ancient human bones in missing layers . . . 113 (1996) 477
Skog, G., see Stenström, K. . . . 113 (1996) 474
Smith, A.M., see Hotchkis, M.A.C. . . . 113 (1996) 457
Smyth, D.L., see Drewell, N.H. . . . 113 (1996) 93
Snelling, H.V., see Can, N. . . . 113 (1996) 248
Soares, J.C., see Rodríguez, T. . . . 113 (1996) 279
Soares, J.C., see Kling, A. . . . 113 (1996) 293
Soltani-Farshi, M., J.D. Meyer, P. Misaelides and K. Bethge, Cross section of the $^{32}S(\alpha, p)^{35}Cl$ nuclear reaction for sulphur determination . . . 113 (1996) 399
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Spädtke, P., see Bessler, U. . . . 113 (1996) 30
Stahl, B., see Walter, G. . . . 113 (1996) 167
Stammbach, Th., S. Adam, H.R. Fitze, W. Joho, M. Märki, M. Olivo, L. Rezzonico, P. Sigg and U. Schryber, The feasibility of high power cyclotrons . . . 113 (1996) 1
Stannard, W.B., see Walker, S.R. . . . 113 (1996) 312
Stein, J., F. Scheuer, W. Gast and A. Georgiev, X-ray detectors with digitized preamplifiers . . . 113 (1996) 141
Steinhausen, C., P. Gerisch, B. Heisinger, Ch. Hohl, G. Kislinger, G. Korschinek, M. Niedermayer, E. Nolte, M. Dumitru, M. Alvarez-Brückmann, M. Schneider and T.H. Ittel, Medical application of ^{26}Al . . . 113 (1996) 479
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Stockhorst, H., see Bechstedt, U. . . . 113 (1996) 26
Storm, W., see Deleu, J. . . . 113 (1996) 534
Straede, C.A., Application of ion implantation in tooling industry . . . 113 (1996) 161
Streitz, H., see Stiebing, K. . . . 113 (1996) 34
Stritt, N., M. Bertschy, J. Jolie and W. Mondelaers, Direct measurement and Monte Carlo simulation of a bremsstrahlung source created by 10 MeV electrons . . . 113 (1996) 150
Stritzker, B., see Wengenmair, H. . . . 113 (1996) 196
Strivay, D., H.P. Garnir and G. Weber, A computer controlled PIGE setup for the analysis of thin samples . . . 113 (1996) 407
Strunk, H.P., see Heft, A. . . . 113 (1996) 239
Sudbrock, F., see Gloris, M. . . . 113 (1996) 429
Sudbrock, F., see Schiekel, Th. . . . 113 (1996) 484
Suter, M., see Nebiker, P.W. . . . 113 (1996) 205
Suter, M., see Dittrich-Hannen, B. . . . 113 (1996) 453
Suter, M., see Parrat, Y. . . . 113 (1996) 470
Suter, M., see Schiekel, Th. . . . 113 (1996) 484
Suter, M., see Wagner, M.J.M. . . . 113 (1996) 490
Symietz, I., H. Baumann and K. Bethge, Diffusion phenomena of implanted nitrogen in chromium . . . 113 (1996) 182
Synal, H.-A., see Parrat, Y. . . . 113 (1996) 470
Synal, H.-A., see Schiekel, Th. . . . 113 (1996) 484
Synal, H.-A., see Wagner, M.J.M. . . . 113 (1996) 490

Tabor, M., see Jongen, Y. . . . 113 (1996) 522
Tachikawa, T., see Jongen, Y. . . . 113 (1996) 522
Tajani, A., see Valkovic, V. . . . 113 (1996) 363
Takács, S., F. Tárkányi and Z. Kovács, Excitation function of alpha-particle induced nuclear reactions on natural nickel . . . 113 (1996) 424
Takahisa, K., see Sato, K. . . . 113 (1996) 42
Takai, M., Applications of nuclear microprobes in the semiconductor industry . . . 113 (1996) 330
Takayama, T., see Jongen, Y. . . . 113 (1996) 522
Tamura, H., see Sato, K. . . . 113 (1996) 42
Tamura, K., see Sato, K. . . . 113 (1996) 42
Tanaka, R., see Ishii, Y. . . . 113 (1996) 75

Tárkányi, F., see Takács, S. 113 (1996) 424
Thomae, R., see Bender, H. 113 (1996) 266
Tinschert, K., D.M. Rück, H. Emig, K. Leible and N. Angert, Ion irradiation facility for materials research at the 1.4 MeV/u high-charge state injector of GSI 113 (1996) 59
Tölle, R., see Bechstedt, U. 113 (1996) 26
Townsend, P.D., see Can, N. 113 (1996) 248
Tuniz, C., see Hotchkis, M.A.C. 113 (1996) 457
Turos, A., Hj. Matzke, A. Drigo, A. Sambo and R. Falcone, Radiation damage in spinel single crystals 113 (1996) 261
Turos, A., see Zaborowski, M. 113 (1996) 191

Uhrmacher, M., see Lupascu, D. 113 (1996) 507
Uraki, M., see Sato, K. 113 (1996) 42

Vacik, J., see Fink, D. 113 (1996) 244
Valkovic, O., see Valkovic, V. 113 (1996) 363
Valkovic, V., M. Dargie, M. Jaksic, A. Markowicz, A. Tajani and O. Valkovic, X-ray emission spectroscopy applied for bulk and individual analysis of airborne particulates 113 (1996) 363
Vandeplassche, D., see Jongen, Y. 113 (1996) 522
Van der Plicht, J., see Wijma, S. 113 (1996) 465
Vandervorst, W., see Deleu, J. 113 (1996) 534
Van IJzendoorn, L.J., M. Haverlag, A. Verbeek, J. Politiek and M.J.A. de Voigt, Quantification of fluorine in SiF_x etch residues on silicon with proton induced γ-emission 113 (1996) 411
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Van Maanen, I.F., P.H.A. Mutsaers, B.A.W. Verhoef and M.J.A. de Voigt, Scanning transmission ion microscopy (STIM) with a 3 MeV proton cyclotron beam 113 (1996) 382
Verbeek, A., see van IJzendoorn, L.J. 113 (1996) 411
Verhoef, B.A.W., see van Maanen, I.F. 113 (1996) 382
Vetterli, D., see Nebiker, P.W. 113 (1996) 205
Viladrosa, R., see Pouvesle, J.M. 113 (1996) 134
Vincent, H., see Somatri, R. 113 (1996) 284
Vis, R.D., see van Kan, J.A. 113 (1996) 373
Vittone, E., see Jakšić, M. 113 (1996) 378
Vlastou, R., E.N. Gazis, C.T. Papadopoulos, E. Liarokapis, D. Palles, S. Kossionides, M. Kokkoris, M. Pilakouta, W. Assmann and H. Huber, An IBA and Raman study of irradiated thin films of $YBa_2Cu_3O_7$ superconductor 113 (1996) 253
Vogt, J., see Krause, H. 113 (1996) 209
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Wagner, M.J.M., B. Dittrich-Hannen, H.-A. Synal, M. Suter and U. Schotterer, Increase of ^{129}I in the environment . . 113 (1996) 490
Wagner, M.J.M., see Dittrich-Hannen, B. 113 (1996) 453
Waldorf, J., Large area ion and plasma beam sources 113 (1996) 8
Walker, S.R., P.N. Johnston, I.F. Bubb, W.B. Stannard, D.N. Jamieson, S.P. Dooley, D.D. Cohen, N. Dytlewski and J.W. Martin, Damage in semiconductor materials during heavy-ion elastic recoil detection analysis 113 (1996) 312
Wallace, S.G., see Forster, J.S. 113 (1996) 308
Walter, G., R. Heitzmann, D.M. Rück, B. Stahl, R. Gellert, O. Geiss, G. Klingelhöfer and E. Kankeleit, Depth resolving phase analysis of ion implanted stainless steel 113 (1996) 167
Weber, G., see Strivay, D. 113 (1996) 407
Wendler, E., see Heft, A. 113 (1996) 239
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Wenzel, T., see Lupascu, D. 113 (1996) 507
Wesch, W., see Heft, A. 113 (1996) 239
Wiebert, A., see Stenström, K. 113 (1996) 474
Wijma, S., A.T. Aerts, J. van der Plicht and A. Zondervan, The Groningen AMS facility 113 (1996) 465
Wilbertz, Ch., see Kalbitzer, S. 113 (1996) 154
Wohlgemuth, R., see Assmann, W. 113 (1996) 303

Wolters, H., see Rodríguez, T. 113 (1996) 279

Xiangyang, L., see Sixun, Y. 113 (1996) 477

Yamada, K., T. Kaneko, K. Kuroda, M. Nakajima and T. Hosokawa, Improving beam profiles in the Super-ALIS super conducting storage ring 113 (1996) 119
Yamagata, T., see Itahashi, T. 113 (1996) 21
Yamaki, S., see Ito, T. 113 (1996) 46
Yamamoto, M., see Sato, K. 113 (1996) 42

Zaborowski, M., G. Gawlik, A. Barcz and A. Turos, Effect of Cr implantation on the morphology of Al:Si films . . . 113 (1996) 191
Zaremba, S., see Jongen, Y. 113 (1996) 522
Zawislak, F.C., see Fink, D. 113 (1996) 244
Zehnder, A., see Hajdas, W. 113 (1996) 54
Zelenitsky, D., see Forster, J.S. 113 (1996) 308
Zhao, X., see Purser, K.H. 113 (1996) 445
Zhao, X.-L., see Kieser, W.E. 113 (1996) 461
Zhiyu, G., see Sixun, Y. 113 (1996) 477
Zondervan, A., see Wijma, S. 113 (1996) 465
Zorba, T., see Paloura, E.C. 113 (1996) 227
Zucchiatti, A., see Formenti, P. 113 (1996) 359